IAP20 RESULTION ET 88 JAN 2006

IN'THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Ken MURAYAMA, et al

Serial No.: not yet assigned

Filed: January 23, 2006

For: PROBE REPLACEMENT METHOD FOR SCANNING PROBE

MICROSCOPE

Group: not yet assigned

Examiner: not yet assigned

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR §1.97 & 1.98

MS Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

January 23, 2006

Sir:

In the matter of the above-identified application, applicants are submitting herewith a copy of a communication from a foreign patent office in a counterpart foreign application and copies of the documents listed in the attached form equivalent to Form PTO-1449 for the Examiner's consideration.

This information disclosure statement is being submitted with the new application.

The documents listed on the attached form equivalent to Form PTO-1449 are not in the English language, the requirement of 37 CFR '1.98(a)(3) for a concise explanation of the relevance is satisfied by the attached English language abstracts.

IAP20 RESCIONTE 23 JAN 2006
It is respectfully requested that this information disclosure statement be considered by the Examiner.

Please charge any shortage in the fees due in connection with the filing of this paper, including extension of time fees, to the deposit account of MATTINGLY, STANGER, MALUR & BRUNDIDGE, P.C., Deposit Account No. 50-1417 (TPO-5168) please credit any excess fees to such deposit account.

Respectfully submitted,

SM/nac (703) 684-1120 Registration No. 34,663

MATTINGLY, STANGER, MALUR & BRUNDIDGE, P.C.

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STATEMENT BY APPLICANT (Use several sheets if necessary)			FILII January 23, 2	NG DATE 2006	GROUP Not Yet Assigned		
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Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date	
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							Yes	No
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1	AN	10-267948	. 10/98	JP			X	
77	AO	2000-329772	11/00	JP		X	X	
W	AP	2002-323426	11/02	JP			X	
/TPN/	AQ	97/08733	3/97	WO				
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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Examiner

/Thomas Noland/

Date Considered
03/29/2009